


<b>Search Notes</b>  	<b>Application/Control No.</b>  10622498	<b>Applicant(s)/Patent Under Reexamination</b>  IWASAKI, TADASHI
	<b>Examiner</b>  Hammond, Crystal L	<b>Art Unit</b>  2819

SEARCHED			
Class	Subclass	Date	Examiner
326	30,86	09/24/2007	clh
327	108	09/24/2007	clh
326	30,86	1/3/2008	clh
327	108	1/3/2008	clh

SEARCH NOTES		
Search Notes	Date	Examiner
consulted with Vibol Tan	09/24/2007	clh
EAST, IEEE, Google text searches	09/24/2007	clh
PLUS search	09/24/2007	clh
INSPEC and Dialog text searches	09/24/2007	clh
consulted with James Cho	1/3/2008	clh
updated EAST, IEEE, Google text searches	1/3/2008	clh
PLUS search	1/3/2008	clh

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
all	all	09/24/2007	clh
all	all	1/3/2008	clh